

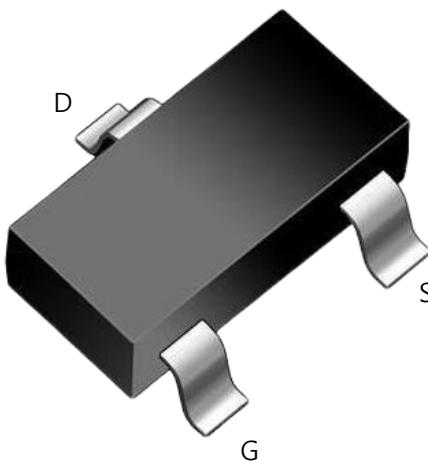
PM011N020SG

20V 6A 11.3mΩ Si Single N-ch Enhancement Mode Power MOSFET with Normal Diode

Features

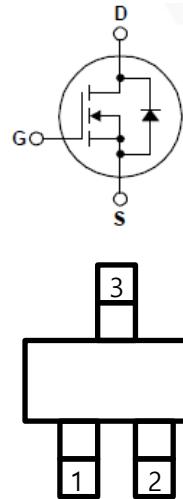
Si Single N-ch Enhancement Mode Power MOSFET

- Rated to 20V at 6Amps @ $T_J = 25^\circ\text{C}$
- Max $R_{DS(on)} = 11.3 \text{ m}\Omega$
- Typ $R_{DS(on)} = 9.5 \text{ m}\Omega$
- Gate Charge(Typ. $Q_g=12.5 \text{ nC}$)
- 100% Avalanche Tested



Application

- DC-DC Converters
- Power switch



PKG type : SOT-23

Pin assignment

Description

The PM011N020SG uses advanced trench technology MOSFETs to provide excellent $R_{DS(ON)}$ and low gate charge. It can be used in a wide variety of applications.

Absolute Maximum Ratings

Symbol	Parameter	Test Condition	Value	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}, I_D=250\mu\text{A}$	20	V
I_D	Drain Current	$T_c=25^\circ\text{C}$	6	A
I_{DM}	Pulsed Drain Current	Pulse width limited by junction temperature	24	A
V_{GS}	Gate-Source Voltage		± 12	V
P_d	Power Dissipation	$T_c=25^\circ\text{C}$	1	W
T_j	Operating Junction Temperature		150	$^\circ\text{C}$
T_{stg}	Storage Temperature		-55 to 150	$^\circ\text{C}$



Package Marking and Ordering Information

Device Marking	Device	Package	Packing Method	Tape width	Quantity
PM011N020SG	PM011N020	SOT-23	-	-	-

Electrical Characteristics of Si MOSFET

Symbol	Parameter	Test Condition	Numerical			Unit
			Min	Typ.	Max.	
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A, T_J = 25^\circ C$	20	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 20V, V_{GS} = 0V$	-	-	1	nA
I_{GSS}	Gate-Source Leakage Current	$V_{GS} = \pm 12V, V_{DS} = 0V$	-	-	± 100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu A$	0.5	0.7	0.9	V
$R_{DS(ON)}$	Static Drain-Source on state resistance	$V_{GS} = 4.5V, I_D = 3A$	-	9.5	11.3	mΩ
g_{FS}	Forward Transconductance	$V_{DS} = 5V, I_D = 3A$	-	24	-	S
$t_{d(on)}$	Turn-on Delay time	$V_{DD} = 4.5 V, I_D = 3A, R_G=3\Omega$	-	2.7	-	ns
T_r	Turn-on Rise time		-	3	-	
$t_{d(off)}$	Turn-off Delay time		-	37	-	
T_f	Turn-off Fall time		-	7	-	



Electrical Characteristics of Si MOSFET

Symbol	Parameter	Test Condition	Numerical		Unit
			Typ.	Max.	
$R_{\theta JA}$	Thermal resistance, Junction to Ambient		120	-	°C/W
C_{iss}	Input capacitance	$V_{DS} = 10V, V_{GS} = 0V, f = 1.0MHz$	1151	-	pF
C_{oss}	Output capacitance		160	-	
C_{rss}	Reverse transfer capacitance		152	-	
$Q_{g(tot)}$	Total gate charge at 10V	$V_{DD} = 4.5V, I_D = 6A$ $V_{GS(on)} = 10V$	12.5	-	nC
Q_{gs}	Gate to source gate charge		1.2	-	
Q_{gd}	Gate to drain "Miller" charge		2.7	-	

Electrical Characteristics of Si Diode

Symbol	Parameter	Test Condition	Numerical		Unit
			Typ.	Max.	
I_S	Maximum continuous drain to source diode forward current		-	6	A
I_{SM}	Maximum pulsed drain to source diode forward current		-	24	A
V_{SD}	Drain to source diode forward voltage	$I_{SD} = 3A, V_{GS} = 0V$	-	1.2	V

Typical Characteristics

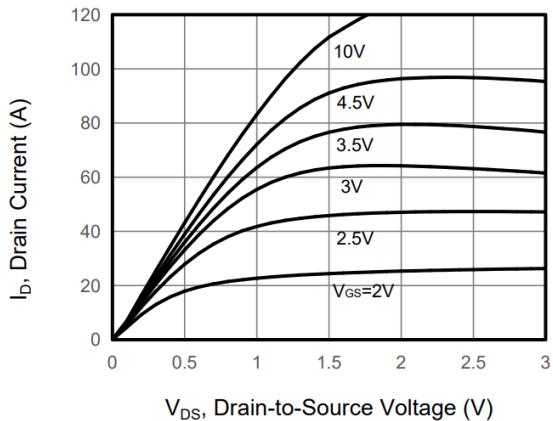


Figure 1. Output Characteristics

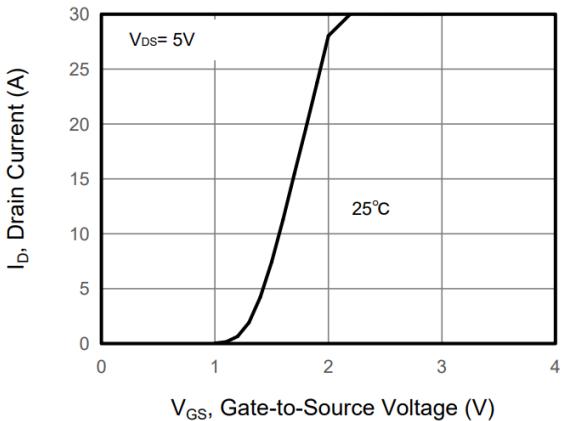


Figure 2. Transfer Characteristics

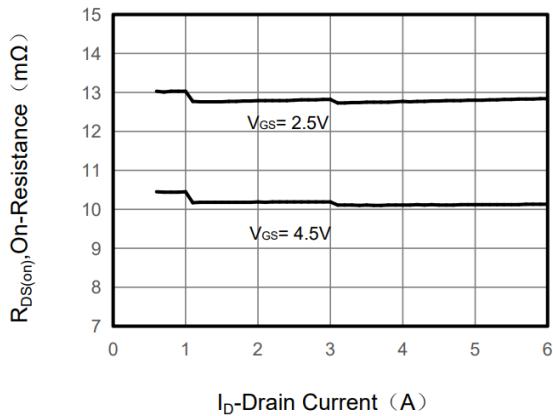


Figure 3. Drain to Source On Resistance

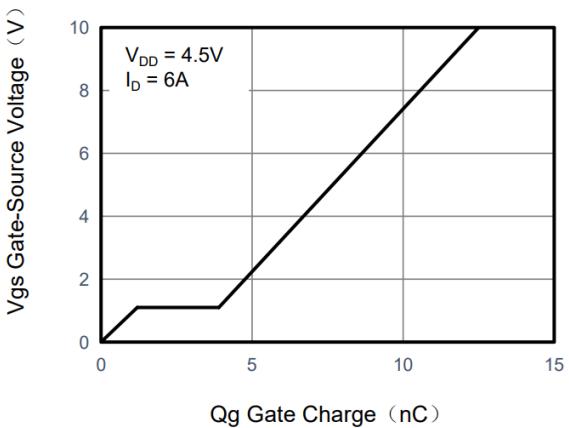


Figure 4. Gate Charge

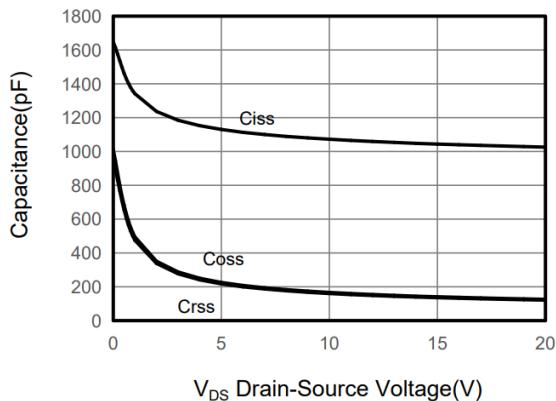


Figure 5. Capacitance Characteristics

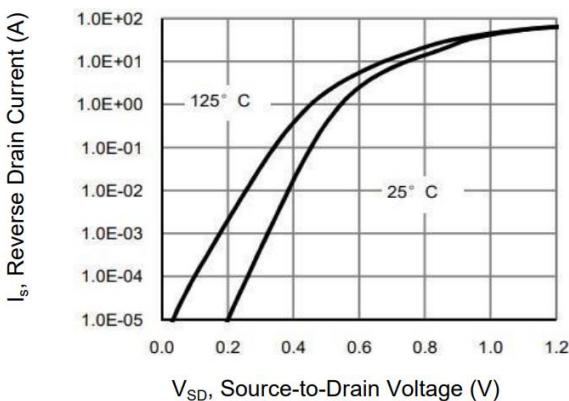


Figure 6. Source to Drain Diode Forward

Typical Characteristics

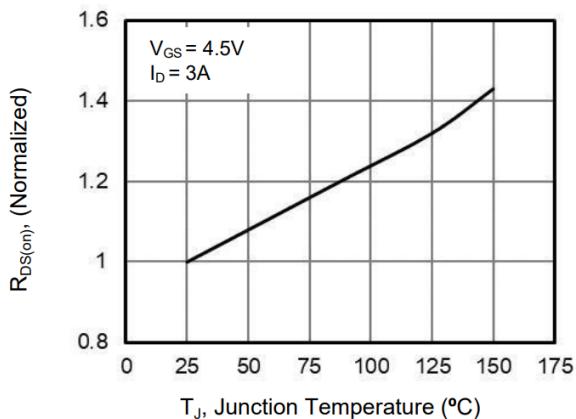


Figure 7. Drain to Source On-Resistance

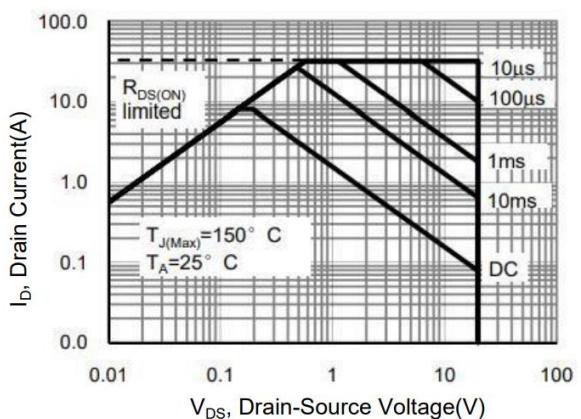


Figure 8. Safe Operation Area

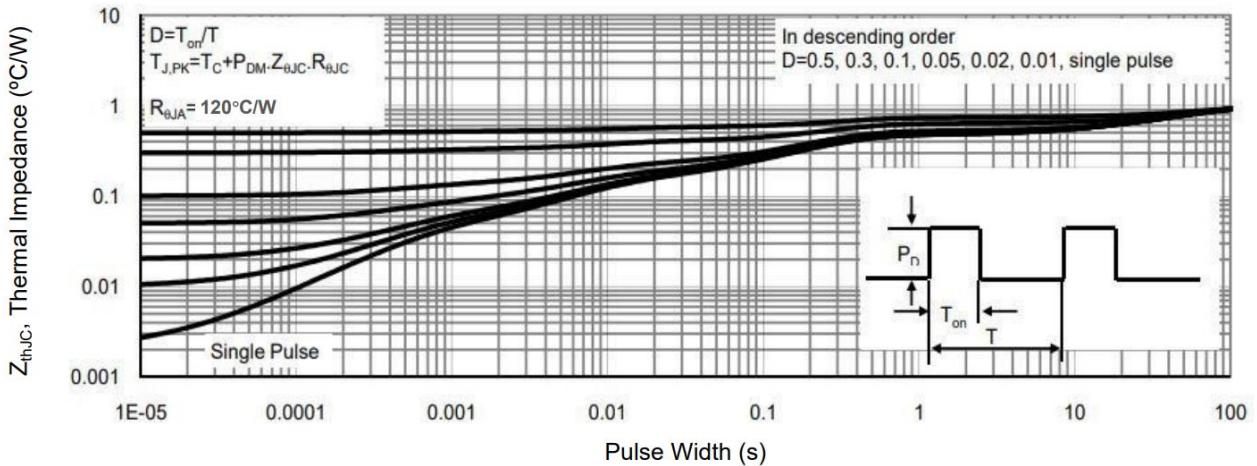
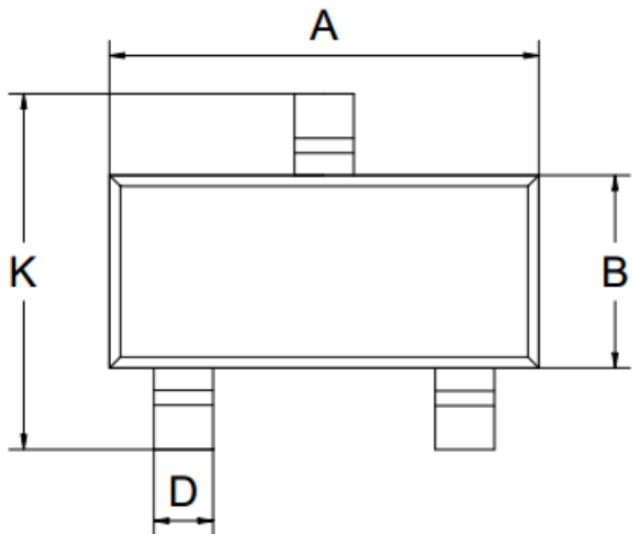


Figure 9. Normalized Maximum Transient Thermal Impedance



Package Outline

Unit : mm



SYMBOL	DIMENSIONS		
	MIN	NOM	MAX
A	2.80	2.90	3.00
B	1.50	1.60	1.70
C	1.00	1.10	1.20
D	0.30	0.40	0.50
E	0.25	0.40	0.55
G	1.90		
H	0.00	-	0.10
J	0.047	0.127	0.207
K	2.60	2.80	3.00

